

Search Notes

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Examiner

Joseph Lauture

Applicant(s)/Patent under
Reexamination

SHIEH ET AL.

Art Unit

2819

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
341	144	8/29/2005	JL
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated Teaxt Search (See Search history printout)	8/25/2005	JL